NSN 6625-01-577-7189

Semiconductor Device Test Set - Page 1 of 1



View Online at https://aerobasegroup.com/nsn/6625-01-577-7189

Ac Voltage Rating:
110.0 volts or 240.0 volts
Frequency Rating:
Between 50.0 hertz and 400.0 hertz
Major Components:
Test set; pair microprobes; common test leads; shrouded test lead; power cord; cd manual
Accessory Component Quantity:
5
Electrical Power Source Relationship:
Operating
Internal Battery Accommodation:
Not included
Inclosure Feature:
Single item w/housing
Test Type For Which Designed:
In-circuit electronic component testing
Product Name:
Test set, semiconductor
Phase:
Single
Functional Classification:
Aa-9.6
Special Features:
Meets mil-prf-28800 class 3
Functional Description:
Used to in-circuit test semiconductor components
Entry Date:
09-09-08
Purchase Description Identification:
98752-pd09wrgbec24
Shelf Life:
N/a
Unit Of Measure:
Demilitarization:
Yes - demil/mli
Fiig:
T228-a
Mil-std (military Standard):
Mil-nrf-28800 spec

Mil-prf-28800 spec.